



Insight into the structural, elastic and electronic properties of a new orthorhombic 6O-SiC polytype

Yassine El Mendili, Beate Orberger, Daniel Chateigner, Jean-François Bardeau, Stéphanie Gascoin, Sébastien Petit, Olivier Pérez, Fouzia Khadraoui

► To cite this version:

Yassine El Mendili, Beate Orberger, Daniel Chateigner, Jean-François Bardeau, Stéphanie Gascoin, et al.. Insight into the structural, elastic and electronic properties of a new orthorhombic 6O-SiC polytype. Scientific Reports, 2020, 10 (1), pp.7562. 10.1038/s41598-020-64415-4 . hal-02899711

HAL Id: hal-02899711

<https://hal.science/hal-02899711>

Submitted on 12 Mar 2021

HAL is a multi-disciplinary open access archive for the deposit and dissemination of scientific research documents, whether they are published or not. The documents may come from teaching and research institutions in France or abroad, or from public or private research centers.

L'archive ouverte pluridisciplinaire **HAL**, est destinée au dépôt et à la diffusion de documents scientifiques de niveau recherche, publiés ou non, émanant des établissements d'enseignement et de recherche français ou étrangers, des laboratoires publics ou privés.



Distributed under a Creative Commons Attribution - NoDerivatives 4.0 International License



OPEN

Insight into the structural, elastic and electronic properties of a new orthorhombic 6O-SiC polytype

Yassine El Mendili^{1,2} , Beate Orberger³, Daniel Chateigner^{1,2} , Jean-François Bardeau⁴, Stéphanie Gascoin² , Sébastien Petit², Olivier Perez² & Fouzia Khadraoui¹

Different polytypes of SiC are described and predicted in literature. Here, we report the first occurrence of an orthorhombic 6O-SiC polytype as rock-forming mineral in the nickel laterite mine of Tiebaghi (New Caledonia). This new class of SiC crystallizes in the space group $Cmc2_1$ with 12 atoms per unit cell [$a = 3.0778(6) \text{ \AA}$, $b = 5.335(2) \text{ \AA}$, $c = 15.1219(6) \text{ \AA}$, $\alpha = 90^\circ$, $\beta = 90^\circ$, $\gamma = 120^\circ$]. The density of 6O-SiC is about 3.22 g/cm^3 and the calculated indirect bandgap at room temperature of 3.56 eV is identical to 6H-SiC. Our results suggest that 6O-SiC is the intermediate state in the wurtzite to rocksalt transformation of 6H-SiC.

SiC is a highly attractive material for fabrication of microelectronic and optoelectronic devices due to its outstanding physical properties, such as a wide bandgap, high thermal conductivity coupled with low thermal expansion. The wide bandgap makes SiC a very attractive semiconductor to make devices for applications in high power, high frequency and high temperature environment^{1–6}. In addition, its high strength gives this material exceptional thermal shock resistant properties and an exceptional hardness^{4–6}.

A large number of SiC polytypes are already described and predicted in literature. The most common polytypes include 3C, 2H, 4H, 6H, 8H, 9R, 10H, 14H, 15R, 19R, 20H, 21H, and 24R^{1,7,8}, where C, H and R mean cubic, hexagonal and rhombohedral symmetries, respectively. Natural SiC, known as moissanite, is extremely rare. Natural occurrences can be divided into three categories: kimberlites⁹, metasomatic rocks¹⁰, peridotites, serpentinites and podiform chromitites^{11,12}.

In this study, different grains of moissanite have been found and separated from the porosities of siliceous breccia originating from hydrofracturing of peridotites at Tiebaghi mine in New Caledonia (Fig. 1a). Moissanite occurs either as single grains or is associated with diamond in composite inclusions (Fig. 1c). These irregular fragments with a size of $10\text{--}75 \text{ \mu m}$ exhibit various colors, including blue, green and yellow (Fig. 1b). Schmidt *et al.*¹³ have suggested that moissanite can be formed at very low temperatures during the alteration of ultramafic rocks, where hydrogen liberated by reactions involving serpentine would induce low oxygen fugacity, 6 to 8 log units below the Iron-Wustite buffer. However, SiC from peridotites and chromites in ophiolites are mainly subhedral to anhedral, and are similar to those observed in the siliceous breccia pores studied in this work. Rapid tectonic uplift would explain that these moissanite crystals are not decomposed to lower temperature phases. This finding suggests that these moissanite grains were liberated from the hostrocks and transported into the breccia pores^{13,14}.

The structural, elastic and electronic properties of this new class of SiC were studied by single crystal X-rays diffraction, Raman spectroscopy and *ab initio* DFT calculation.

In this study, the optical microscopy analysis of the siliceous breccia porosities shows the presence of different crystals of moissanite. EDS analyzes confirm that all the moissanite crystals are mainly composed of C and Si (Fig. 1d).

¹COMUE Normandie Université – Laboratoire ESITC - ESITC Caen, 1 Rue Pierre et Marie Curie, 14610, Epron, France. ²CRISMAT-ENSICAEN, UMR CNRS 6508, Université de Caen Normandie, IUT Caen, Normandie Université, 6 boulevard Maréchal Juin, 14050, Caen, France. ³GEOPS, Université Paris Saclay-Paris Sud, UMR 8148 (CNRS-UPS), Bât 504, 91405, Orsay, France. ⁴IMMM, Le Mans Université, UMR6283 CNRS, Avenue Olivier Messiaen, 72085, Le Mans, France. ✉e-mail: yassine.el-mendili@esitc-caen.fr

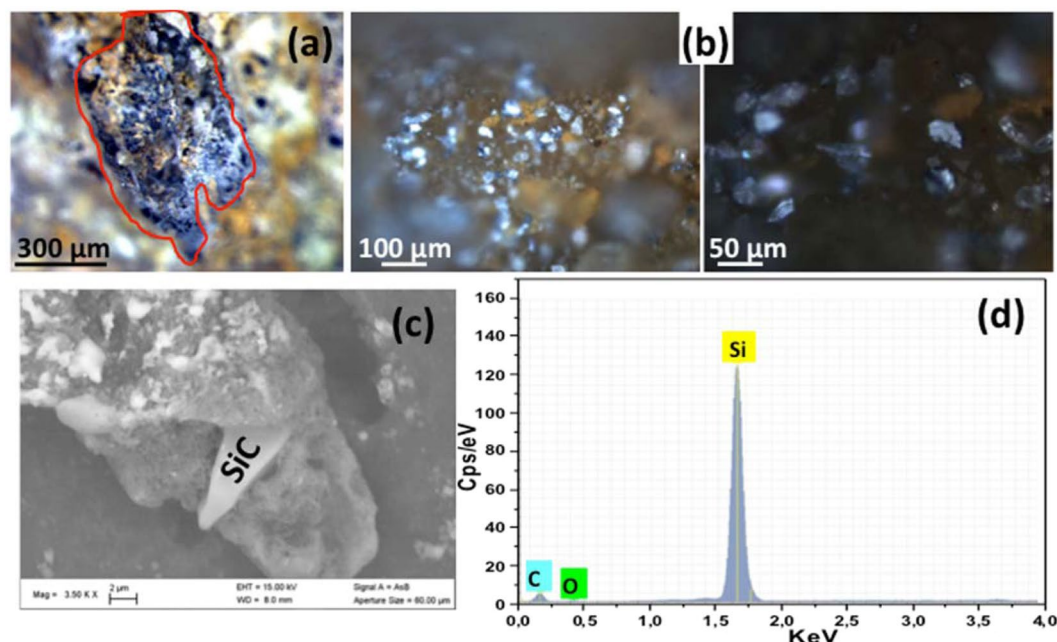


Figure 1. Porosities of siliceous breccia (a) Binocular image of siliceous breccia porosities, (b) Optical images of SiC present in porosities at two different magnifications (c) SEM image showing diamond cluster bearing-SiC extracted from breccia porosities and (d) EDS spectrum of SiC.

Structural properties of SiC

An extracted grain with a dark blue color and largest dimensions smaller than $10 \times 10 \times 10 \mu\text{m}^3$ was selected for SCXRD experiments (Fig. 2). A full data collection has been performed on a Rigaku Synergy S single crystal diffractometer equipped with a Cu micro focus X-ray source and a Dectris Eiger 1M photon counting detector. A first analysis of the full diffraction pattern has been done using the 6H-SiC polytype with the cell parameters $a \approx 3.078 \text{ \AA}$, $b \approx 3.078 \text{ \AA}$, $c \approx 15.13 \text{ \AA}$, $\alpha = 90^\circ$, $\beta = 90^\circ$ and $\gamma = 120^\circ$ ¹⁵; unindexed reflections inducing a doubling of the a and b periodicities are observed. The data integration was performed using CrysAlispro [CrysAlisPro Software System, Version 1.171.39.46, Rigaku] and the new unit cell is $a = 6.165(4) \text{ \AA}$, $b = 6.169(4) \text{ \AA}$, $c = 15.129(10) \text{ \AA}$, $\alpha = 89.95(5)^\circ$, $\beta = 89.97(5)^\circ$, $\gamma = 119.96(7)^\circ$. An internal reliability factor (R_{int}) showed from the intensities of symmetry equivalent reflections that the deviation from the Laue classes $6/mmm$, $6/m$, -3 , $-3m$ or $-31m$ is always larger than 52%. This excludes unambiguously the hexagonal or trigonal symmetries. The reciprocal space was then interpreted considering the orthorhombic unit cell $a = 3.0778(6) \text{ \AA}$, $b = 5.335(2) \text{ \AA}$, $c = 15.1219(6) \text{ \AA}$, $\alpha = 90^\circ$, $\beta = 90^\circ$ and $\gamma = 90^\circ$ and twin components related by a three-fold axis parallel to c . The new integration leads to a R_{int} value of about 12% for the mmm Laue class. This value far to be perfect suggests an imperfect data quality certainly related to the tiny dimension of the crystal. Nevertheless, the structure has been determined by charge – flipping method¹⁶ with Superflip¹⁷ in the Cmc_2 space group and then refined using Jana2006¹⁸. Cmc_2 being non centrosymmetric, 3 additional twin domains have to be introduced. But only 3 twin domains related by a three fold axis have been found as significant from their respective intensities; the twin volume ratio are the following: 38(5)%, 36(5)% and 26(5)%. The final agreement factor is $R_f = 0.0329(2)$ for 316 reflections with $I \geq 3\sigma(I)$ and 20 refinement parameters. A view of the structure is presented in Fig. 2c. The main structural characteristics of the 6H-SiC polytype are described as SiC_4 tetrahedra sharing all their edges with their neighbours.

The crystal packing of 6O-SiC can be described by means of two alternating layers tilted with respect to one another by an angle close to 120° . However, slight differences can be noted compared to the hexagonal polytype. The 3 independent SiC_4 groups are exhibiting distortions as evidenced by the Si-C bond lengths varying from 1.866(9) to 1.92(2) $\text{\AA}$ as well as by the Si-C-Si angles ranging from 107.8° to 111.2° which corresponds to deviations of nearly $\pm 2^\circ$ with respect to the values reported for cubic and hexagonal polytypes. This phenomenon is usually called planarization, a flattening of the tetrahedra correlated to an increase in bond angle. This leads to a non-centrosymmetric orthorhombic structure.

The structure can then be described by alternating a periodic stacking of blocks following the sequence ... ABCACB... along the $[0001]$ direction, illustrating the existence of six types of block boundaries (Fig. 2d). The atomic positions of the 6O-SiC polytype are given in Table 1.

In literature, 6H polytype is formed at very high temperatures (2300–2800 K) and at least at pressures of 3 GPa¹⁹. Because of the similarities between the polymorphism in SiC and ZnS, the transition models that have served as frameworks to study the wurtzite to rocksalt transition are the same for SiC. The high-pressure transition from the 6H wurtzite to the 3C rocksalt structure in SiC has been explored extensively with the help of computations^{20–22}. It also has been observed in shock compression experiments at a pressure of 105 GPa²². It is found by *ab initio* calculations that 6H polytype under high temperature-pressure undergoes a transition to the

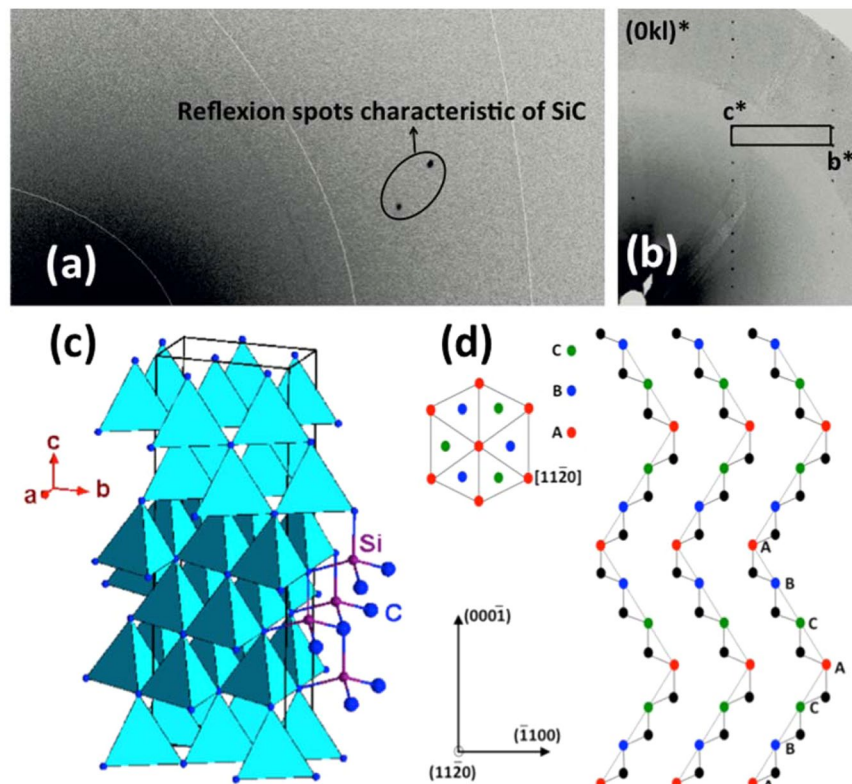


Figure 2. Single crystal diffraction experiment on 6O-SiC twinned single crystal. (a) one experimental frame exhibiting diffraction spots of SiC, (b) Part of the $(0kl)^*$ reciprocal plane of SiC assembled from the whole experimental frames. Reciprocal cell parameters and unit cell are drawn, (c) crystal structure refined in an orthorhombic 6O-SiC model and (d) stacking sequence of the 6O-SiC in the (1120) plane.

Atom	Occupancy	x	y	z	$U_{iso} (\text{\AA}^2)$
Si1	1	0	0.8327(15)	0.858(1)	0.0050(11)
Si2	1	0.5	-0.0007(6)	0.5241(4)	0.0055(5)
Si3	1	0.5	0.6643(14)	0.69124(12)	0.0057(11)
C1	1	0	0.504(3)	0.6503(7)	0.0009(16)
C2	1	0	0.840(4)	0.9817(5)	0.0062(16)
C3	1	0.5	0.671(4)	0.8168(5)	0.0081(18)

Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters for the orthorhombic 6O-SiC refined structure.

rocksalt structure through an orthorhombic intermediate state²⁰. The space groups of the transition states are identified as $Pmm2$ and $Imm2$ ²⁰. Our results are particularly important because they suggest that the wurtzite to rock-salt phase transitions pass through the intermediate states with $Cmc2_1$ symmetry. It is interesting to note that an intermediate orthorhombic phase with $Cmc2_1$ symmetry has also been described in previous works for the same transition in different semiconductors such as GaN, InN, CdS and CdSe²³. The finding of this new SiC structure being an intermediate phase between wurtzite and rock salt transition is in the line with the geodynamic context of the sample. Indeed, these SiC microcrystals occur together with diamond, and other reduced phases (Fe-Mn alloys, Al-rich chromite). These phases most likely crystallized in the lower mantle²⁴. Second stage boninitic melts, described at Tiebaghi (New Caledonia)^{25,26}, served as a natural elevator to transport these ultrahigh-pressure, reducing phases into the upper mantle. These resistant phases survived hydrothermal and superegene alteration.

Elastic properties of SiC

The elastic constant tensors of 3C-, 6H- and 6O-SiC crystals, determined by Brillouin scattering, are listed in Table 2 along with available computed and experimental elastic constants. Using the second order elastic constants, the bulk modulus B is computed.

In general, the intrinsic mechanical stability of a solid is determined by certain conditions concerning the C_{ij} values related to the crystal symmetry. For an orthorhombic crystal, the independent elastic stiffness tensor

Structures	Space group	Methods	B	C_{11}	C_{12}	C_{13}	C_{22}	C_{23}	C_{33}	C_{44}	C_{55}	C_{66}	Reference
3C-SiC	F-43m	Theoretical	213	382	128	—	—	—	—	239	—	—	⁴¹
			214	406	118	—	—	—	—	255	—	—	This work
		Experimental	215	395	123	—	—	—	—	236	—	—	⁴²
6H-SiC	P6 ₃ mc	Theoretical	214	470	103	50	—	—	493	168	—	—	⁴³
			215	507	95	43	—	—	555	176	—	—	This work
		Experimental	220	501	111	52	—	—	553	163	—	—	⁴⁴
6O-SiC	Cmc2 ₁	Theoretical	215	507	95	43	507	43	555	176	176	206	This work

Table 2. Calculated elastic constants (C_{ij} in GPa) and bulk modulus (B in GPa) of 3C-, 6H and 6O- SiC.

reduces to nine components C_{11} , C_{22} , C_{33} , C_{44} , C_{55} , C_{66} , C_{12} , C_{13} and C_{23} in the Voigt notation. The elastic components C_{11} , C_{22} and C_{33} represent the elastic stiffness along the three-unit cell directions. The other constants are associated with either mixed behaviours (C_{ij} 's with $i \neq j$) or shears (C_{44} , C_{55} and C_{66}). The Born stability criteria²⁷ for an orthorhombic system are:

$$B1 = C_{11} + C_{22} + C_{33} + 2(C_{12} + C_{13} + C_{23}) > 0 \quad (1)$$

$$B2 = C_{11} + C_{22} - 2C_{12} > 0 \quad (2)$$

$$B3 = C_{11} + C_{33} - 2C_{13} > 0 \quad (3)$$

$$B4 = C_{22} + C_{33} - 2C_{23} > 0 \quad (4)$$

The computed $B1$, $B2$, $B3$, and $B4$ values for the 6O-SiC are all positive with 1243, 824, 976, and 976 GPa, respectively. All the four conditions for mechanical stability are simultaneously satisfied and this clearly indicates that this orthorhombic polytype is a mechanically stable phase. C_{44} is an important parameter indirectly governing the indentation hardness of a material. The studied Cmc2₁ structure possesses a large C_{44} value of 175 GPa, meaning its relatively strong strength against shear deformation. The bulk modulus B of 3C, 6H and 6O structures are similar ($B \approx 215$ GPa), which is the indication of high hardness of these semiconductor materials. The C_{33} value is superior to C_{11} and C_{22} values, showing the compressibility along the ab -plane to be more pronounced than along the c -axis, towards a more anisotropic phase compared to 3C and 6H. Elastic constants yield the compressibility of the c axis smaller than the a and b axis (0.0018 versus 0.0021 and 0.0021 GPa⁻¹).

Vibrational properties of SiC

The Raman-active vibrational modes of our orthorhombic SiC were calculated through Density Functional Theory (DFT). For comparison, we also calculated the Raman spectra for cubic SiC and hexagonal 6H-SiC. 6H-SiC is among the most interesting SiC polytype for power electronic applications. Moreover, 6H-SiC exhibits high breakdown electric field, high thermal conductivity and a wide band gap of 3.1 eV at room temperature⁴. In addition, this polytype is the most abundant one occurring in terrestrial rocks.

The Raman spectra of SiC polytypes present in siliceous breccia pores are shown in Fig. 3a. We can detect three of the SiC polytypes: 3C, 6H and 6O.

References to standard transverse acoustic and optical phonons (TA and TO resp.), and longitudinal optical and acoustic phonons (LO and LA resp.) were obtained from literature for different polytypes²⁸.

For 3C-SiC, only two strong Raman bands are observed at 972 cm⁻¹ and 796 cm⁻¹ assigned to the longitudinal E_1 (LO) and transverse A_1 (TO) optical phonon modes, respectively. For 6H-SiC, the experimental characteristic phonon modes are assigned as follows²⁸: E_2 (TA) at 151 cm⁻¹, E_1 (TA) at 240 cm⁻¹, A_1 (LA) at 504 cm⁻¹, E_2 (TO) at 762 and 783 cm⁻¹, E_1 (TO) at 791 cm⁻¹ and A_1 (LO) at 887 and 963 cm⁻¹.

In the case of 6O-SiC, the main Raman modes were confirmed and matched with Raman-active vibrational modes in the orthorhombic Cmc2₁ structure. According to group theory, the orthorhombic Cmc2₁ structure with 12 atoms per unit cell gives rise to 33 Raman-active modes and factor group analysis gives irreducible mechanical representations for optical modes as $\Gamma_{\text{opt}} = 11A_1 + 6A_2 + 11B_1 + 5B_2$, which are all Raman active. Table 3 shows the vibrational modes of 6O-SiC obtained by DFT calculations and observed experimentally by Raman spectroscopy.

We can notice that the Raman spectral features of the 6H- and 6O-SiC polytypes are close to each other. This similarity confirms the results obtained by SCXRD meaning that the structural properties of these two polytypes are very close.

The pressure dependence of the Raman vibration modes in 6H-SiC was measured up to 95 GPa^{29,30}. In these studies^{29,30}, the optical modes are all shifted to higher wavenumbers with pressure. Consequently, based on the comparison between the 6O and 6H vibrational modes, we can attribute the shift of the main intense modes to a variation of pressure. The strongest optical modes A_1 for 6O-SiC are present at 786 cm⁻¹, while for 6H-SiC the strongest band E_2 (TO) is present at 783 cm⁻¹. Similar observation can be made for the 2 other optical transverse modes of 6H, E_2 (TO) and E_1 (TO) present at 762 cm⁻¹ and at 791 cm⁻¹, respectively, shifted by about 5 cm⁻¹ towards high wavenumbers in 6O-SiC. Then, according to the pressure dependence of the vibration modes wavenumbers^{29,30}, the observed shifts correspond to an increase in isostatic pressure close to 1 GPa. Accordingly, this suggests that the 6O polytype was formed at very high temperatures (2027–2527 °C) and at minimum pressures of 4 GPa.

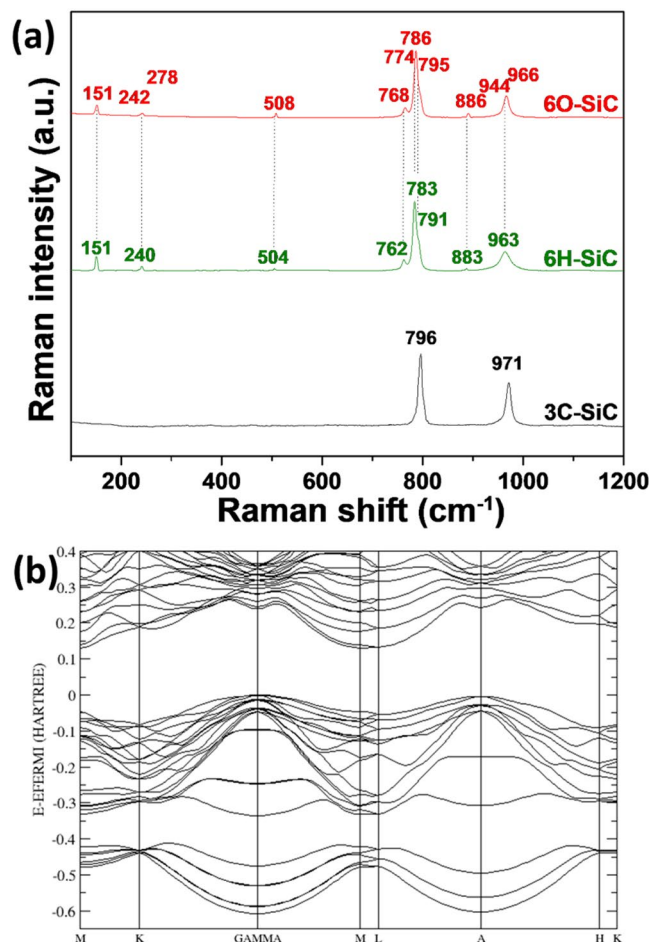


Figure 3. (a) Raman spectra of three different SiC crystals present in the siliceous porosities and (b) calculated electronic band structure of 6O-SiC.

Electronic properties of SiC

In Fig. 3b, we show the calculated bulk band structure of 6O-SiC using the Density Functional Theory. The results show that 6O-SiC is an indirect band gap semiconductor with the top valence band located at Γ of the Brillouin zone and the conduction band edge along the M - L symmetry line. The calculated indirect bandgaps for 3C, 6H and 6O-SiC are 2.90, 3.56 eV and 3.56 eV, respectively (Table 4). We notice that our calculations underestimate the experimental bandgap of the 3C and 6H SiC⁴ polytypes. However, since the calculated indirect bandgap value of the 6O-SiC is equal to that of 6H polytype, we can reasonably expect that the real indirect bandgap of the 6O polytype is around 3.10 eV.

In this study, we report the first occurrence of an orthorhombic 6O-SiC polytype as rock-forming mineral. 6O-SiC crystallizes in the space group $Cmc2_1$ with 12 atoms per unit cell. These findings establish a novel SiC mechanically stable phase with a density value close to that of 6H-SiC. The calculated indirect bandgap of 6H and 6O-SiC at room temperature are equals.

Among the SiC polytypes, 6H is the most easily synthesized and the best studied. For instance, 6H-SiC has been found to be very suitable substrates for GaN epitaxial layers for the deposition of laser diodes³¹.

The question that remains unresolved is if this new 6O-SiC structure can be also easily prepared, given its superior density? Most probably deposition as thin heteroepitaxial structures on single crystal substrates, known to stabilize films at large, GPa-like equivalent pressures, may allow future studies of this new phase.

Methods

Sample materials. Moissanite studied here naturally occurred in siliceous breccia rock (SB; SOLSA label: ER-NC00-0001) from Tiebaghi mine in New Caledonia. Tiebaghi is a mine and former village in Kaala-Gomen, New Caledonia, located on an ultramafic massif. The siliceous breccia samples are solid, porous beige rocks (pore size can reach cm scale). The breccia hosts lithoclasts of brownish-dark grey saprolite. Locally reddish spots occur, originating from weathering.

SEM/EDS measurements. Imaging and compositional analysis were performed using scanning electron microscope JEOL JSM-6400 equipped with an X-ray energy dispersive system (SEM/EDS) operating at 20 kV and sensitive to elements with atomic numbers from Na to U.

Polytype					
6O-SiC				6H-SiC	
Vibrational modes/ Symmetries	DFT		Experimental (cm^{-1}) $\pm$ 0.3	Vibrational modes/ Symmetries ²⁸	Experimental (cm^{-1}) $\pm$ 0.3
	Predicted wavenumber (cm^{-1})	Predicted intensity			
A ₂	150	vw	151 w	E ₂ (TA)	151 w
A ₁	150.1	vw			
A ₁	152.9	vw			
A ₂	153.1	vw			
B ₁	245.6	vw			
B ₂	245.8	vw	242 vw	E ₁ (TA)	240 vw
B ₁	249.7	vw			
B ₂	249.8	vw			
A ₁	278.8	vw			
A ₂	279	vw	278 vw	—	—
B ₁	281.7	—			
B ₁	283.8	—			
A ₁	509	vw	509 vw	A ₁ (LA)	504 vw
A ₁	515	vw			
B ₁	618.9	—	Not observed	—	—
A ₁	761.5	m			
A ₂	762.7	m	768 m	E ₂ (TO)	762 m
B ₁	765.5	vw			
B ₂	766.8	vw			
B ₁	774.5	vw	774 w	—	—
B ₂	775.4	vw			
A ₁	787.2	s			
A ₂	788	s	786 s	E ₂ (TO)	783 s
A ₁	788.6	m			
A ₁	788.9	s			
A ₂	790	vw			
B ₁	797.8	m	797 m	E ₁ (TO)	791 m
B ₂	798.8	m			
B ₁	838.7	—	Not observed	—	—
A ₁	885.9	vw	891 vw	A ₁ (LO)	887 vw
A ₁	891.1	vw			
B ₁	943.8	vw	944 vw	—	—
B ₁	969.4	m	966 m	A ₁ (LO)	963 m

Table 3. Theoretical and experimental Raman-active vibrational modes of 6O-SiC. The symmetries are based on those calculated by DFT. vw: very weak, w- weak, m: medium and s: strong.

Materials	Space group	Energy gap (eV)	
		Theoretical (this study)	Experimental
3C-SiC	F-43m	2.90 (indirect)	2.40 (indirect)
6H-SiC	P6 ₃ mc	3.56 (indirect)	3.10 (indirect)
6O-SiC	Cmc2 ₁	3.56 (indirect)	—

Table 4. Calculated and experimental energy gaps of the 3C, 6H and 6O structures. Experimental data are taken for SiC from reference ⁴.

Micro-Raman measurements. The Raman spectra were recorded at room temperature using a DXR Raman microscope (Thermo Fisher Scientific, Inc., USA) equipped with a 900 lines/mm diffracting grating. The highest quality spectra (highest signal-to-noise) were obtained using green excitation (532 nm, Nd: YAG laser). Raman measurements were carried out at low laser power (approximately 1 mW at the sample surface) to avoid unintentionally heating alteration, structural modifications or phase transitions. A 100x magnification long working distance objective was used to focus the laser onto the sample and collect the scattered light in a backscattering geometry. Raw data was collected over a range of 80–2200 cm^{-1} . The spectral region 3200–4000 cm^{-1} was

investigated for some minerals species when OH stretching vibration modes were potentially expected. The spot diameter of the laser was estimated at 0.6 μm . Raman spectra were systematically recorded twice with an integration time of 60 s. For each mineral, 5 spectra were recorded and averaged. Peak deconvolution and integration were performed with the Origin software using the Gaussian-Lorentzian function.

SCXRD measurements. Single crystal X-ray diffraction. A Synergy S Rigaku 4-circles diffractometer equipped with Cu micro focus source and an Eiger 1M Dectric detector has been used to analyze the SiC grains. A full data collection was performed on the highest quality sample. The analysis of the reciprocal space is done using *Crysalis^{Pro}* software³². The structure has been solved using Superflip software¹⁷ and refined with Jana2006¹⁸.

Computational details. The Raman-active vibrational modes of 6H-SiC were calculated through Density Functional Theory (DFT) as implemented in the Crystal17 package³³. The B3LYP approximation was used and the wave functions were expanded as a linear combination of Bloch functions using Gaussian-type atomic orbitals (6–31 G*)³⁴. The Coulomb and exchange series were truncated with overlap thresholds of 10^{-8} , 10^{-8} , 10^{-8} , 10^{-8} and 10^{-16} . A Monkhorst-Pack sampling scheme of $16 \times 16 \times 16$ for cubic SiC, $16 \times 16 \times 10$ for hexagonal 6H-SiC and orthorhombic SiC were chosen after some tests. The convergence threshold on energy for the self-consistent-field procedure was fixed at 10^{-10} Hartree for structural optimizations and for vibration frequency calculations. Frequencies at the Gamma point were evaluated within the harmonic approximation as implemented in Crystal17^{35,36}. The Raman intensities of the vibrational modes were calculated analytically by exploiting the scheme described by Maschio *et al.*^{37,38} at ambient temperature and an exciting wavelength of 532 nm. This scheme is based on the solutions of first and second-order coupled Perturbed-Hartree-Fock/Kohn-Sham (CPHF/KS) equations^{39,40}. For the calculation of the elastic constants, we have used the default settings on size of lattice deformation (0.01 Å) and 3 points, including the central point with zero displacement for the numerical second derivatives calculations. We have used the default energy and force convergence criteria for vibrational frequency and elastic constants calculations as defined by Crystal17. These convergence criteria are typically tighter than separate. The band structure and DOS of the models were constructed along the appropriate high-symmetry directions of the corresponding irreducible Brillouin zone.

Data availability

The experimental and computational data that support the findings of this study are available from the corresponding author upon request.

Received: 28 October 2019; Accepted: 15 April 2020;

Published online: 05 May 2020

References

- Cheung, R. Silicon Carbide Microelectromechanical Systems for Harsh Environments. Imperial College Press, Ch.3, ISBN 1860946240 (2006).
- Shiryaev, A. A., Griffin, W. L., Stoyanov, E. & Kagi, H. Natural silicon carbide from different geological settings: polytypes, trace elements, inclusions. 9th International Kimberlite Conference Extended, Abstract No. 9IKC-A-00075 (2008).
- Zetterling, C. M. *Process Technology for Silicon Carbide Devices*. EMIS processing series, no. 2, INSPEC, IEE, UK (2002).
- Yoshida, S. In Properties of Silicon Carbide (G. L. Harris (ed.), EMIS Data-review Series No. 13, INSPEC, London, (1995).
- Ou, H. *et al.* Advances in wide bandgap SiC for optoelectronics. *M. Eur. Phys. J. B* **87**, 58 (2014).
- Wellmann, P. J. Power Electronic Semiconductor Materials for Automotive and Energy Saving Applications – SiC, GaN, Ga₂O₃, and Diamond. *Z. Anorg. Allg. Chem.* **643**, 1312–1322 (2017).
- Kaiser, U., Chuvilin, A., Brown, P. D. & Richter, W. Origin of Threefold Periodicity in High-Resolution Transmission Electron Microscopy Images of Thin Film Cubic SiC. *Microsc. Microanal.* **5**, 420–427 (1999).
- Yaghoubi, A., Singh, R. & Melinon, P. Predicting the primitive form of rhombohedral silicon carbide (9R-SiC): A pathway toward polytypic heterojunctions. *Cryst. Growth. Design* **18**, 7059–7064 (2018).
- Shiryaev, A. A., Griffin, W. L. & Stoyanov, E. Moissanite (SiC) from kimberlites: Polytypes, trace elements, inclusions and speculations on origin. *Lithos.* **122**, 152–164 (2011).
- Di Pierro, S. *et al.* Rock-forming moissanite (natural silicon carbide). *Am. Mineral.* **88**, 1817–1821 (2003).
- Xu, S. *et al.* Moissanite in serpentinite from the Dabie Mountains in China. *Mineral. Magazine.* **72**, 899–908 (2008).
- Bai, W. *et al.* The PGE and base-metal alloys in the podiform chromitites of the Luobasa ophiolite, southern Tibet. *Can. Mineral.* **38**, 585–598 (2000).
- Schmidt, M. W., Gao, C., Golubkova, A., Rohrbach, A. & Connolly, J. A. Natural moissanite (SiC) – a low temperature mineral formed from highly fractionated ultra-reducing COH-fluids. *Prog. Earth. Planet. Sci.* **1**, 27–30 (2014).
- Mitchell, R. H. Kimberlites and lamproites: primary sources of diamond. *Geosci. Can.* **18**, 1–16 (1991).
- Capitani, G. C., Di Pierro, S. & Tempesta, G. The 6H-SiC structure model: Further refinement from SCXRD data from a terrestrial moissanite. *Am. Mineral.* **92**, 403–407 (2015).
- Oszlanyi, G. & Suto, A. Ab initio structure solution by charge flipping. *Acta. Cryst.* **A60**, 134–141 (2004).
- Palatinus, L. & Chapuis, G. SUPERFLIP, a computer program for the solution of crystal structures by charge flipping in arbitrary dimensions. *J. Appl. Cryst.* **40**, 786–790 (2007).
- Petríček, V., Dušek, M. & Palatinus, L. Crystallographic Computing System JANA2006: General features. *Z. Kristallogr.* **229**, 345–352 (2014).
- Daviau, K. & Lee, K. K. M. Decomposition of silicon carbide at high pressures and temperatures. *Phys. Rev. B* **96**, 174102 (2017).
- Catti, M. Orthorhombic Intermediate State in the Zinc Blende to Rocksalt Transformation Path of SiC at High pressure. *Phys. Rev. Lett.* **87**, 035504 (2001).
- Sekine, T. & Kobayashi, T. Shock compression of 6H polytype SiC to 160 GPa. *Phys. Rev. B* **55**, 8034 (1997). Pressure. *Phys. Rev. Lett.* **87**, 035504 (2001).
- Lu, Y. P., He, D. W., Zhu, J. & Yang, X. D. First-principles study of pressure-induced phase transition in silicon carbide. *Phys. B* **403**, 3543–3546 (2008).
- Stokes, H. T. *et al.* Bilayer sliding mechanism for the wurtzite-to-rocksalt transition. *Phys. Rev. B* **76**, 012102 (2007).
- Trumbull, R. B. *et al.* The carbon isotope composition of natural SiC (moissanite) from the Earth's mantle: New discoveries from ophiolites. *Lithos.* **113**, 612–620 (2009).

25. Campiglio, C., Marion, C. & Vannier, M. Etude d'une boninite à olivine de Nouvelle-Calédonie: pétrographie et chimisme des phases. *Bull. Minéral.* **109**, 423–440 (1986).
26. Bailly, L. *et al.* Nickel-Typologie des minéral latéritiques de Nouvelle-Calédonie et facteurs de concentration de Co et Ni., Volume II, CNRT « Nickel et son environnement », p. 448 (2014).
27. Ravindran, P. *et al.* Density functional theory for calculation of elastic properties of orthorhombic crystals: application to TiSi₂. *J. Appl. Phys.* **84**, 4891–904 (1998).
28. Nakashima, S. & Harima, H. Raman Investigation of SiC Polytypes. *Physica. Status. Solidi* **162**, 39–64 (1997).
29. Liu, J. & Vohra, Y. K. Raman modes of 6H polytype of silicon carbide to ultrahigh pressures: A comparison with silicon and diamond. *Phys. Rev. Lett.* **72**, 4105 (1994).
30. Daviau, K. & Lee, K. M. High-Pressure, High-Temperature Behavior of Silicon Carbide: A Review. *Crystals*. **8**, 217 (2018).
31. Zhang, L. *et al.* Influence of stress in GaN crystals grown by HVPE on MOCVD-GaN/6H-SiC substrate. *Sci. Reports* **4**, 4179 (2014).
32. CrysAlisPro Software System, Version 1.171.38.41. Rigaku Oxford Diffraction, <http://www.rigaku.com>.
33. Dovesi, R. *et al.* CRYSTAL14: A program for the ab initio investigation of crystalline solids. *Int. J. Quantum Chem.* **114**, 1287–1317 (2014).
34. Gatti, C., Saunders, V. R. & Roetti, C. Crystal field effects on the topological properties of the electron density in molecular crystals: The case of urea. *J. Chem. Phys.* **101**, 10686–10696 (1994).
35. Pascale, F. *et al.* The calculation of the vibrational frequencies of crystalline compounds and its implementation in the CRYSTAL code. *J. Comput. Chem.* **25**, 888–897 (2004).
36. Zicovich-Wilson, C. *et al.* Calculation of the vibration frequencies of α -quartz: The effect of Hamiltonian and basis set. *J. Comput. Chem.* **25**, 1873–1881 (2004).
37. Maschio, L., Kirtman, B., Rerat, M., Orlando, R. & Dovesi, R. Ab initio analytical Raman intensities for periodic systems through a coupled perturbed Hartree-Fock/Kohn-Sham method in an atomic orbital basis. I. Theory. *J. Chem. Phys.* **139**, 164101 (2013).
38. Maschio, L., Kirtman, B., Rerat, M., Orlando, R. & Dovesi, R. Ab initio analytical Raman intensities for periodic systems through a coupled perturbed Hartree-Fock/Kohn-Sham method in an atomic orbital basis. II. Validation and comparison with experiments. *J. Chem. Phys.* **139**, 164102 (2013).
39. Ferrero, M., Rerat, M., Orlando, R. & Dovesi, R. The calculation of static polarizabilities of 1-3D periodic compounds. the implementation in the crystal code. *J. Comput. Chem.* **29**, 1450–1459 (2008).
40. Ferrero, M., Rerat, M., Orlando, R. & Dovesi, R. Coupled perturbed Hartree-Fock for periodic systems: The role of symmetry and related computational aspects. *J. Chem. Phys.* **128**, 014110 (2008).
41. Pizzagalli, L. Stability and mobility of screw dislocations in 4H, 2H and 3C silicon carbide. *Acta. Materialia*. **78**, 236–244 (2014).
42. Stockmeier, M. *et al.* Thermal Expansion Coefficients of 6H Silicon Carbide. *Mater. Sci. Forum.* **600–603**, 517–520 (2009).
43. Huang, H., Ghoniem, N. M., Wong, J. K. & Baskes, M. I. Molecular dynamics determination of defect energetics in β -SiC using three representative empirical potentials. *Modell. Simul. Mater. Sci. Eng* **3**, 615–627 (1995).
44. Kamitani, K. *et al.* The elastic constants of siliconcarbide: a Brillouin-scattering study of 4H and 6H SiC single crystals. *J. Appl. Phys.* **82**, 3152–3154 (1997).

Acknowledgements

We thank the European Commission for having sponsored this study in the frame of the SOLSA project (H2020 program): SC5-11d-689868. The DFT calculation work was done with the support of the French national computer center IDRIS under project no. 081842 and the regional computer center CRIANN under project no. 2007013.

Author contributions

Y.E. performed the Raman measurements. Y.E., S.G. and D.C. carried out scanning electron microscopy studies. J.-F.B. performed additional Raman measurements and contributed to data analysis. S.P. performed the DFT calculations. F.K. contributed to elastic discussion. B.O. contributed to geological analysis and discussion on the SiC origin, O.P. performed the single crystal X-ray diffraction experiments and Y.E. wrote the manuscript with input from all authors. All authors discussed the results of the manuscript.

Competing interests

The authors declare no competing interests.

Additional information

Correspondence and requests for materials should be addressed to Y.E.

Reprints and permissions information is available at www.nature.com/reprints.

Publisher's note Springer Nature remains neutral with regard to jurisdictional claims in published maps and institutional affiliations.



Open Access This article is licensed under a Creative Commons Attribution 4.0 International License, which permits use, sharing, adaptation, distribution and reproduction in any medium or format, as long as you give appropriate credit to the original author(s) and the source, provide a link to the Creative Commons license, and indicate if changes were made. The images or other third party material in this article are included in the article's Creative Commons license, unless indicated otherwise in a credit line to the material. If material is not included in the article's Creative Commons license and your intended use is not permitted by statutory regulation or exceeds the permitted use, you will need to obtain permission directly from the copyright holder. To view a copy of this license, visit <http://creativecommons.org/licenses/by/4.0/>.

© The Author(s) 2020